Search	notes
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Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/814,367	TAN ET AL.	
Examiner	Art Unit	
Hoang V. Nguyen	2821	

SEARCHED			
Class	Subclass	Date	Examiner
343	700MS	5/25/2005	НИ
343	702	5/25/2005	HN
343	846	5/25/2005	HN
343	746	5/25/2005	HN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	5/25/2005	HN
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